



SLOVENSKI STANDARD
oSIST prEN IEC 62522:2023
01-april-2023

Umerjanje nastavljivih laserskih virov

Calibration of tuneable laser sources

Kalibrierung von abstimmbaren Laserquellen

Étalonnage des sources laser accordables

Ta slovenski standard je istoveten z: prEN IEC 62522:2023

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TITLE:

Calibration of tuneable laser sources

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NOTE FROM TC/SC OFFICERS:

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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CALIBRATION OF TUNEABLE LASER SOURCES

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99

FOREWORD

- 100 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising
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132 IEC 62522 has been prepared by IEC technical committee 86: Fibre optics. It is an International
133 Standard.

134 This second edition cancels and replaces the first edition published in 2014. This edition
135 constitutes a technical revision.

136 This edition includes the following significant technical changes with respect to the previous
137 edition:

- 138 a) Addition of IEC 61315 in the Normative references (and reference to);
139 b) Addition of Tables 1 and 2 on uncertainties;
140 c) Clarify the settings of the reference power meter in 6.2.3 and 6.3.2.3.

141 The text of this International Standard is based on the following documents:

Draft	Report on voting
XX/XX/FDIS	XX/XX/RVD

142 Full information on the voting for its approval can be found in the report on voting indicated in
143 the above table.
144

145 The language used for the development of this International Standard is English.

146 This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in
147 accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available
148 at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are
149 described in greater detail at www.iec.ch/standardsdev/publications.

150 The committee has decided that the contents of this document will remain unchanged until the
151 stability date indicated on the IEC website under webstore.iec.ch in the data related to the
152 specific document. At this date, the document will be

- 153 • reconfirmed,
- 154 • withdrawn,
- 155 • replaced by a revised edition, or
- 156 • amended.

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158

INTRODUCTION

159 Wavelength-division multiplexing (WDM) transmission systems have been deployed in optical
160 trunk lines. ITU-T Recommendations in the G.694 series describe the frequency and wavelength
161 grids for WDM applications. For example, the frequency grid of G.694.1 supports a variety of
162 channel spacing ranging from 12,5 GHz to 100 GHz and wider. WDM devices, such as arrayed
163 waveguide grating (AWG), thin film filter or grating based multiplexers (MUX), and
164 demultiplexers (DMUX) with narrow channel spacing are incorporated in the WDM transmission
165 systems. When measuring the characteristics of such devices, wavelength tuneable laser
166 sources are commonly used and are required to have well-calibrated performances; wavelength
167 uncertainty, wavelength tuning repeatability, wavelength stability, and output optical power
168 stability are important parameters.

169 The tuneable laser source (TLS) is generally equipped with the following features:

- 170 a) the output wavelength is continuously tuneable in a wavelength range starting at 1 260 nm
171 or higher and ending at less than 1 675 nm (the output should excite only the fundamental
172 LP01 fibre mode);
- 173 b) an output port for optical fibre connectors.

174 The envelope of the spectrum is a single longitudinal mode with a FWHM of at most 0,1 nm.
175 Any adjacent modes are at least 20 dB lower than the main spectral mode (for example, a
176 distributed feedback laser diode (DFB-LD), external cavity laser, etc.)

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CALIBRATION OF TUNEABLE LASER SOURCES

180 **1 Scope**

181 This document provides a stable and reproducible procedure to calibrate the wavelength and
182 power output of a tuneable laser against reference instrumentation such as optical power
183 meters and optical wavelength meters (including optical frequency meters) that have been
184 previously traceably calibrated.

185 **2 Normative references**

186 The following documents are referred to in the text in such a way that some or all of their content
187 constitutes requirements of this document. For dated references, only the edition cited applies.
188 For undated references, the latest edition of the referenced document (including any
189 amendments) applies.

190 IEC 60793-2-50, *Optical fibres – Part 2-50: Product specifications – Sectional specification for*
191 *class B single-mode fibres*

192 IEC 60825-1, *Safety of laser products – Part 1: Equipment classification and requirements*

193 IEC 60825-2, *Safety of laser products – Part 2: Safety of optical fibre communication systems*
194 *(OFCS)*

195 IEC 61315, *Calibration of fibre-optic power meters*

196 IEC 62129-2, *Calibration of wavelength/optical frequency measurement instruments – Part 2:*
197 *Michelson interferometer single wavelength meters*

198 ISO/IEC 17025, *General requirements for the competence of testing and calibration*
199 *laboratories*

200 ISO/IEC Guide 98-3:2008, *Uncertainty of measurement – Part 3: Guide to the expression of*
201 *uncertainty in measurement (GUM:1995)*

202 ISO/IEC Guide 99:2007, *International vocabulary of metrology – Basic and general concepts*
203 *and associated terms (VIM)*

204 **3 Terms, definitions and abbreviations**

205 **3.1 Terms and definitions**

206 For the purposes of this document, the following terms and definitions apply.

207 ISO and IEC maintain terminological databases for use in standardization at the following
208 addresses:

- 209 • IEC Electropedia: available at <https://www.electropedia.org/>
- 210 • ISO Online browsing platform: available at <https://www.iso.org/obp>

211 **3.1.1**

212 **accredited calibration laboratory**

213 calibration laboratory authorized by an appropriate national organization to issue calibration
214 certificates that demonstrates traceability to national standards

215 **3.1.2**
 216 **adjustment**
 217 set of operations carried out on an instrument in order that it provides given indications
 218 corresponding to given values of the measurand

219 [SOURCE: IEC 60050-300:2001, 311-03-16, modified – minor editorial change, omission of the
 220 NOTE]

221 [See also ISO/IEC Guide 99:2007, 3.11, modified – 3 NOTES omitted].

222 **3.1.3**
 223 **calibration**
 224 set of operations that establish, under specified conditions, the relationship between the values
 225 of quantities indicated by a measuring instrument and the corresponding values realized by
 226 standards

227 Note 1 to entry: The results of a calibration permit either the assignment of measurand values to the indications or
 228 the determination of corrections with respect to the indications.

229 Note 2 to entry: A calibration may also determine other metrological properties such as the effects of influence
 230 quantities.

231 Note 3 to entry: The result of a calibration may be recorded in a document, called a calibration certificate or a
 232 calibration report.

233 [SOURCE: ISO/IEC Guide 99:2007, 2.39, modified – shortened; the two NOTES replaced by 3
 234 new NOTES].

235 **3.1.4**
 236 **calibration conditions**
 237 conditions of measurement in which the calibration is performed

238 **3.1.5**
 239 **calibration at reference conditions**
 240 calibration which includes the evaluation of the uncertainty at reference conditions of the light
 241 source under calibration

242 **3.1.6**
 243 **calibration at operating conditions**
 244 calibration which includes the evaluation of the uncertainty at operating conditions of the light
 245 source under calibration

246 **3.1.7**
 247 **level of confidence**
 248 estimated probability that the true value of a measured parameter lies in the given range

249 **3.1.8**
 250 **coverage factor**
 251 k
 252 used to calculate the expanded uncertainty U from the standard uncertainty, u

253 **3.1.9**
 254 **optical power deviation**
 255 D_P
 256 difference between the set power of the light source under calibration, P_{TLS} , and the
 257 corresponding reference power P_{meas} , measured by the reference power meter

258
$$D_P = \frac{P_{\text{TLS}} - P_{\text{meas}}}{P_{\text{meas}}}$$

259 Note 1 to entry: Power P is expressed in linear units, e.g. W

260 3.1.10

261 operating conditions

262 appropriate set of specified ranges of values with influence quantities usually wider than the
263 reference conditions for which the uncertainties of a measuring instrument are specified

264 Note 1 to entry: Operating conditions and the uncertainty at operating conditions are usually specified by the
265 manufacturer for the convenience of the user.

266 3.1.11

267 reference conditions

268 conditions used for testing the performance of a measuring instrument or for the
269 intercomparison of the measurement results

270 Note 1 to entry: Reference conditions generally include reference values or reference ranges for the quantities
271 influencing and affecting the measuring instrument.

272 3.1.12

273 side-mode suppression ratio

274 SMSR

275 peak power ratio between the main mode spectrum and the largest side mode spectrum in a
276 single-mode laser diode such as a DFB-LD

277 Note 1 to entry: Side-mode suppression ratio is usually expressed in dB.

278 3.1.13

279 wavelength

280 wavelength (in a vacuum) of a light source

281 3.1.14

282 wavelength deviation

283 D_λ

284 difference between the target wavelength, set on the light source under calibration, λ_{TLS} , and
285 the measured wavelength, λ_{meas} , in nm or μm

$$286 \quad D_\lambda = \lambda_{\text{TLS}} - \lambda_{\text{meas}}$$

287 3.2 Abbreviations

APC	angled physical contact
DFB-LD	distributed feedback laser diode
FWHM	full-width/half-maximum
OSA	optical spectrum analyser
SMSR	side-mode suppression ration
TLS	tuneable laser source
WDM	wavelength-division multiplexing

288 4 Preparation for calibration

289 4.1 Organization

290 The calibration laboratory should satisfy requirements of ISO/IEC 17025.

291 There shall be a documented measurement procedure for each type of calibration performed,
292 giving step-by-step operating instructions and equipment to be used.

293 4.2 Traceability

294 The requirements of ISO/IEC 17025 should be met.

295 All standards used in the calibration process shall be calibrated according to a documented
296 program with traceability to national standards laboratories or to accredited calibration
297 laboratories.

298 It is advisable to maintain more than one standard on each hierarchical level, so that the
299 performance of the standard can be verified by comparisons on the same level. Make sure that
300 any other calibration equipment which have a significant influence on the calibration results are
301 calibrated.

302 4.3 Preparation

303 The environmental conditions shall be commensurate with the level of uncertainty that is
304 required for calibration:

- 305 a) calibrations shall be carried out in a clean environment;
- 306 b) temperature monitoring and control is required;
- 307 c) all laser sources shall be safely operated (refer to IEC 60825-1 and IEC 60825-2);
- 308 d) the output of the tuneable laser source should be examined with an optical spectrum
309 analyser (OSA) to check for single mode operation.

310 The recommended temperature is 23 °C (for example, 23 °C ± 2 °C). Give the calibration
311 equipment a minimum of 2 h prior to testing to reach equilibrium within its environment. Allow
312 the tuneable laser source a warm-up period in accordance to the manufacturer's instructions.

313 4.4 Reference calibration conditions

314 The reference calibration conditions usually include the following parameters and, if necessary,
315 their tolerance bands: date, temperature, relative humidity, atmospheric pressure, displayed
316 optical power, displayed wavelength, fibre, connector-adapter combination, (spectral)
317 bandwidth and resolution bandwidth (spectral resolution) set. Unless otherwise specified, use
318 a single-mode optical fibre category B1.1 or B1.3 pigtail as prescribed by IEC 60793-2-50,
319 having a length of at least 2 m. It is desirable to perform all the calibration in a situation where
320 back-reflections are negligible. Thus, angled connectors and isolators should be used wherever
321 the situation permits.

322 Operate the tuneable laser source in accordance with the manufacturer's specifications and
323 operating procedures. Where practical, select a range of calibration conditions and parameters
324 that emulate the actual field operating conditions of the tuneable laser source under calibration.
325 Choose these parameters so as to optimize the tuneable laser source's accuracy, as specified
326 by the manufacturer's operating procedures.

327 Document the conditions as specified in Clause 7.

328 NOTE The calibration results only apply to the set of calibration conditions used in the calibration process.

329 5 Wavelength calibration

330 5.1 Overview

331 The factors making up the uncertainty in the wavelength of the light source under calibration
332 consist of